

## **Search Notes**



**Application/Control No.**

10/518,367

Examiner

Tran N. Nguyen

**Applicant(s)/Patent under  
Reexamination**

SHIGA ET AL.

Art Unit

2834

## **INTERFERENCE SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**